


<b>Search Notes</b>  	<b>Application/Control No.</b>  10718642	<b>Applicant(s)/Patent Under Reexamination</b>  LEUNG ET AL.
	<b>Examiner</b>  Tran, TuyetLien	<b>Art Unit</b>  2179

SEARCHED			
Class	Subclass	Date	Examiner
715	773	5/29/07	KTD
715	702	6/24/10	TT
345	173	6/24/10	TT

SEARCH NOTES		
Search Notes	Date	Examiner
updated East text search (see attached):US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	12/04/06	KTD
updated East text search (see attached):US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	1/7/08	KTD
updated East text search (see attached):US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	8/1/08	KTD
Updated East text search (see attached)	11/7/08	KTD
Updated East text search (see attached)	4/30/09	KTD
Updated East text search (see attached)	11/6/09	KTD
Updated East text search (see attached)	2/24/10	KTD
update EAST search (see attached)	6/24/10	TT
update EAST (see attached)	10/12/10	TT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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